

<b>Search Notes</b>  	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10790478	CHEN ET AL.
	<b>Examiner</b>  Park, Edward	<b>Art Unit</b>  2609

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
(348/61,76,77) text search only - see search history printouts	1/31/07	EP
(375/240.01) text search only - see search history printouts	1/31/07	EP
(382/103,107,128) text search only - see search history printouts	1/31/07	EP
(455/100,67,11,67,13,95) text search only - see search history printouts	1/31/07	EP
(600/101,104,112,109,476,593,424,700,160,117) text search only - see search history printouts	1/31/07	EP
(128/903) text search only - see search history printouts	1/31/07	EP
(700/17,246,250,66,83,65) text search only - see search history printouts	1/31/07	EP

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>